


<b>Search Notes</b> 	<b>Application/Control No.</b> 10540570	<b>Applicant(s)/Patent Under Reexamination</b> TAKAHASHI ET AL.
	<b>Examiner</b> Arun S Phasge	<b>Art Unit</b> 1795

SEARCHED			
Class	Subclass	Date	Examiner
204	632	12/17/08	asp

SEARCH NOTES		
Search Notes	Date	Examiner
inventor name searched in EDAN	12/10/08	asp

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--